

1AP20Rec'd PCT/PTO 30 MAY 2006

Sheet 1 of 1

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 0001.1195	APPLICATION NO. 10/580911
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		FIRST NAMED INVENTOR Ki-Hyun Kim et al.	
		FILING DATE May 30, 2006	GROUP/ART UNIT

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	6,081,909	06/2000	Luby et al.			
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
	AG	WO 02/095965 A1	11/2002	WIPO		
	AH	WO 02/099976 A2	12/2002	WIPO		
	AI	WO 02/099976 A3	12/2002	WIPO		
	AJ					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

			TRANSLATION YES NO
	AK	Gallager, Robert G., "Low-Density Parity-Check Codes" pp. 2-90, July 1963	
	AL	Mackay, David J.C., "Good Error-Correcting Codes Based on Very Sparse Matrices" IEEE Transactions on Information Theory, vol. 45, no. 2, pp. 399-431, 1999.	

EXAMINER /Esaw Abraham/	DATE CONSIDERED 09/13/2010
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Revised November 2004

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /EA/